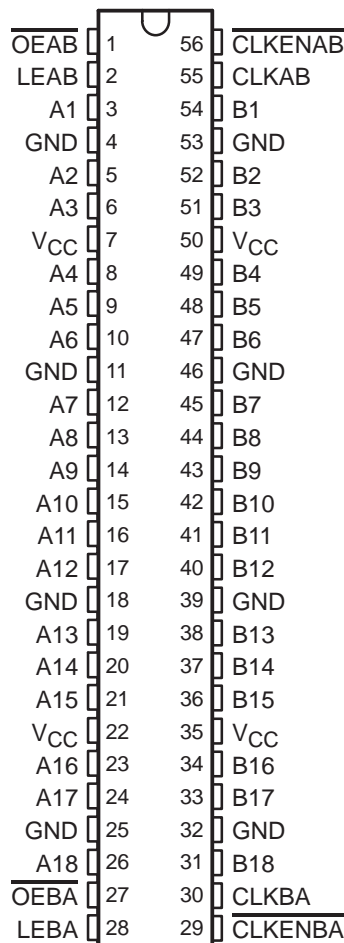


SN54ALVTH16601, SN74ALVTH16601 2.5-V/3.3-V 18-BIT UNIVERSAL BUS TRANSCEIVER WITH 3-STATE OUTPUTS

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- **UBT™ (Universal Bus Transceiver) Combines D-Type Latches and D-Type Flip-Flops for Operation in Transparent, Latched, Clocked, or Clock-Enabled Mode**
- **State-of-the-Art Advanced BiCMOS Technology (ABT) *Widebus*™ Design for 2.5-V and 3.3-V Operation and Low Static-Power Dissipation**
- **Support Mixed-Mode Signal Operation (5-V Input and Output Voltages With 2.3-V to 3.6-V V_{CC})**
- **Typical V_{OLP} (Output Ground Bounce) <0.8 V at $V_{CC} = 3.3$ V, $T_A = 25^\circ\text{C}$**
- **High-Drive ($-24/24$ mA at 2.5-V and $-32/64$ mA at 3.3-V V_{CC})**
- **I_{off} and Power-Up 3-State Support Hot Insertion**
- **Use Bus Hold on Data Inputs in Place of External Pullup/Pulldown Resistors to Prevent the Bus From Floating**
- **Auto3-State Eliminates Bus Current Loading When Output Exceeds $V_{CC} + 0.5$ V**
- **Flow-Through Architecture Facilitates Printed Circuit Board Layout**
- **Distributed V_{CC} and GND Pin Configuration Minimizes High-Speed Switching Noise**
- **ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model ($C = 200$ pF, $R = 0$)**
- **Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II**
- **Package Options Include Plastic Shrink Small-Outline (DL), Thin Shrink Small-Outline (DGG), Thin Very Small-Outline (DGV) Packages, and 380-mil Fine-Pitch Ceramic Flat (WD) Package**

SN54ALVTH16601 . . . WD PACKAGE
SN74ALVTH16601 . . . DGG, DGV, OR DL PACKAGE
(TOP VIEW)



NOTE: For tape and reel order entry:
The DGGR package is abbreviated to GR and
the DGVR package is abbreviated to VR.

description

The 'ALVTH16601 devices are 18-bit universal bus transceivers designed for 2.5-V or 3.3-V V_{CC} operation, but with the capability to provide a TTL interface to a 5-V system environment.

The devices combine D-type latches and D-type flip-flops to allow data flow in transparent, latched, and clocked modes.



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description (continued)

Data flow in each direction is controlled by output-enable (\overline{OEAB} and \overline{OEBA}), latch-enable (LEAB and LEBA), and clock (CLKAB and CLKBA) inputs. The clock can be controlled by the clock-enable ($\overline{CLKENAB}$ and $\overline{CLKENBA}$) inputs. For A-to-B data flow, the device operates in the transparent mode when LEAB is high. When LEAB is low, the A data is latched if CLKAB is held at a high or low logic level. If LEAB is low, the A data is stored in the latch/flip-flop on the low-to-high transition of CLKAB. Output enable \overline{OEAB} is active low. When \overline{OEAB} is low, the outputs are active. When \overline{OEAB} is high, the outputs are in the high-impedance state.

Data flow for B to A is similar to that of A to B, but uses \overline{OEBA} , LEBA, CLKBA, and $\overline{CLKENBA}$.

This device is fully specified for hot-insertion applications using I_{off} and power-up 3-state. The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down. The power-up 3-state circuitry places the outputs in the high-impedance state during power up and power down, which prevents driver conflict.

When V_{CC} is between 0 and 1.2 V, the device is in the high-impedance state during power up or power down. However, to ensure the high-impedance state above 1.2 V, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

Active bus-hold circuitry is provided to hold unused or floating data inputs at a valid logic level.

The SN54ALVTH16601 is characterized for operation over the full military temperature range of -55°C to 125°C . The SN74ALVTH16601 is characterized for operation from -40°C to 85°C .

FUNCTION TABLE†

INPUTS					OUTPUT
$\overline{CLKENAB}$	\overline{OEAB}	LEAB	CLKAB	A	B
X	H	X	X	X	Z
X	L	H	X	L	L
X	L	H	X	H	H
H	L	L	X	X	B_0^{\ddagger}
H	L	L	X	X	B_0^{\ddagger}
L	L	L	↑	L	L
L	L	L	↑	H	H
L	L	L	L or H	X	B_0^{\ddagger}

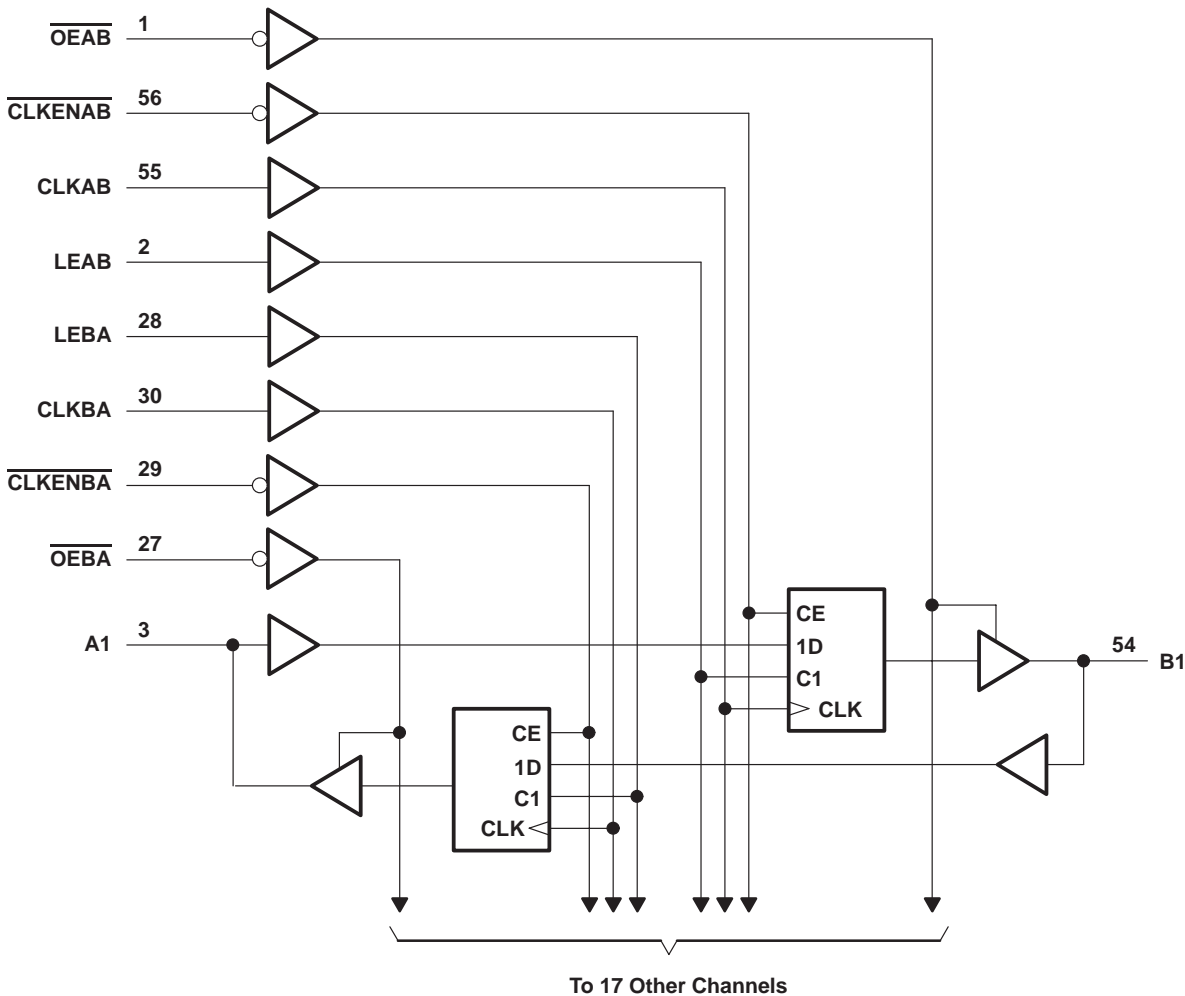
† A-to-B data flow is shown; B-to-A flow is similar but uses \overline{OEBA} , LEBA, CLKBA, and $\overline{CLKENBA}$.

‡ Output level before the indicated steady-state input conditions were established

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logic diagram (positive logic)



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V_{CC}	–0.5 V to 4.6 V
Input voltage range, V_I (see Note 1)	–0.5 V to 7 V
Voltage range applied to any output in the high or power-off state, V_O (see Note 1)	–0.5 V to 7 V
Output current in the low state, I_O : SN54ALVTH16601	96 mA
SN74ALVTH16601	128 mA
Output current in the high state, I_O : SN54ALVTH16601	–48 mA
SN74ALVTH16601	–64 mA
Input clamp current, I_{IK} ($V_I < 0$)	–50 mA
Output clamp current, I_{OK} ($V_O < 0$)	–50 mA
Package thermal impedance, θ_{JA} (see Note 2): DGG package	81°C/W
DGV package	86°C/W
DL package	74°C/W
Storage temperature range, T_{stg}	–65°C to 150°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
2. The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions, $V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}$ (see Note 3)

		SN54ALVTH16601			SN74ALVTH16601			UNIT
		MIN	TYP	MAX	MIN	TYP	MAX	
V_{CC}	Supply voltage	2.3		2.7	2.3		2.7	V
V_{IH}	High-level input voltage	1.7			1.7			V
V_{IL}	Low-level input voltage			0.7			0.7	V
V_I	Input voltage	0	V_{CC}	5.5	0	V_{CC}	5.5	V
I_{OH}	High-level output current			–6			–8	mA
I_{OL}	Low-level output current			6			8	mA
	Low-level output current; current duty cycle $\leq 50\%$; $f \geq 1\text{ kHz}$			18			24	
$\Delta t/\Delta v$	Input transition rise or fall rate			10			10	ns/V
$\Delta t/\Delta V_{CC}$	Power-up ramp rate	200			200			$\mu\text{s/V}$
T_A	Operating free-air temperature	–55		125	–40		85	°C

NOTE 3: All unused control inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

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recommended operating conditions, $V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$ (see Note 3)

		SN54ALVTH16601			SN74ALVTH16601			UNIT
		MIN	TYP	MAX	MIN	TYP	MAX	
V_{CC}	Supply voltage	3		3.6	3		3.6	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.8			0.8	V
V_I	Input voltage	0	V_{CC}	5.5	0	V_{CC}	5.5	V
I_{OH}	High-level output current			-24			-32	mA
I_{OL}	Low-level output current			24			32	mA
	Low-level output current; current duty cycle $\leq 50\%$; $f \geq 1\text{ kHz}$			48			64	
$\Delta t/\Delta v$	Input transition rise or fall rate			10			10	ns/V
$\Delta t/\Delta V_{CC}$	Power-up ramp rate	200			200			$\mu\text{s/V}$
T_A	Operating free-air temperature	-55		125	-40		85	$^{\circ}\text{C}$

NOTE 3: All unused control inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

SN54ALVTH16601, SN74ALVTH16601

2.5-V/3.3-V 18-BIT UNIVERSAL BUS TRANSCEIVER

WITH 3-STATE OUTPUTS

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electrical characteristics over recommended operating free-air temperature range,
 $V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN54ALVTH16601		SN74ALVTH16601		UNIT
			MIN	TYP†	MAX	MIN	
V_{IK}	$V_{CC} = 2.3\text{ V}$, $I_I = -18\text{ mA}$		-1.2		-1.2		V
V_{OH}	$V_{CC} = 2.3\text{ V to } 2.7\text{ V}$, $I_{OH} = -100\text{ }\mu\text{A}$		$V_{CC}-0.2$		$V_{CC}-0.2$		V
	$V_{CC} = 2.3\text{ V}$	$I_{OH} = -6\text{ mA}$	1.8		1.8		
V_{OL}	$V_{CC} = 2.3\text{ V to } 2.7\text{ V}$, $I_{OL} = 100\text{ }\mu\text{A}$		0.2		0.2		V
	$V_{CC} = 2.3\text{ V}$	$I_{OL} = 6\text{ mA}$	0.4		0.4		
		$I_{OL} = 8\text{ mA}$	0.5		0.5		
		$I_{OL} = 24\text{ mA}$	0.5		0.5		
V_{RST}^\ddagger	$V_{CC} = 2.7\text{ V}$	$I_O = 1\text{ mA}$, $V_I = V_{CC}$ or GND	0.55		0.55		V
I_I	Control inputs	$V_{CC} = 2.7\text{ V}$, $V_I = V_{CC}$ or GND	± 1		± 1		μA
		$V_{CC} = 0$ or 2.7 V , $V_I = 5.5\text{ V}$	10		10		
	A or B ports	$V_{CC} = 2.7\text{ V}$, $V_I = 5.5\text{ V}$	10		10		
		$V_{CC} = 2.7\text{ V}$, $V_I = V_{CC}$	1		1		
		$V_I = 0$	-5		-5		
I_{off}	$V_{CC} = 0$,	V_I or $V_O = 0$ to 4.5 V			± 100		μA
I_{BHL}^\S	$V_{CC} = 2.3\text{ V}$,	$V_I = 0.7\text{ V}$	115		115		μA
I_{BHH}^\P	$V_{CC} = 2.3\text{ V}$,	$V_I = 1.7\text{ V}$	-10		-10		μA
$I_{BHLO}^\#$	$V_{CC} = 2.7\text{ V}$,	$V_I = 0$ to V_{CC}	300		300		μA
I_{BHHO}^\parallel	$V_{CC} = 2.7\text{ V}$,	$V_I = 0$ to V_{CC}	-300		-300		μA
I_{EX}^\star	$V_{CC} = 2.3\text{ V}$,	$V_O = 5.5\text{ V}$	125		125		μA
$I_{OZ}(\text{PU/PD})^\square$	$V_{CC} \leq 1.2\text{ V}$, $V_O = 0.5\text{ V to } V_{CC}$, $V_I = \text{GND or } V_{CC}$, $\overline{OE} = \text{don't care}$		± 100		± 100		μA
I_{CC}	$V_{CC} = 2.7\text{ V}$, $I_O = 0$, $V_I = V_{CC}$ or GND	Outputs high	0.04	0.1	0.04	0.1	mA
		Outputs low	2.5	4.5	2.5	4.5	
		Outputs disabled	0.04	0.1	0.04	0.1	
C_i	$V_{CC} = 2.5\text{ V}$,	$V_I = 2.5\text{ V or } 0$	3		3		pF
C_{io}	$V_{CC} = 2.5\text{ V}$,	$V_O = 2.5\text{ V or } 0$	7		7		pF

† All typical values are at $V_{CC} = 2.5\text{ V}$, $T_A = 25^\circ\text{C}$.

‡ Data must not be loaded into the flip-flops/latches after applying power.

§ The bus-hold circuit can sink at least the minimum low sustaining current at V_{IL} max. I_{BHL} should be measured after lowering V_{IN} to GND and then raising it to V_{IL} max.

¶ The bus-hold circuit can source at least the minimum high sustaining current at V_{IH} min. I_{BHH} should be measured after raising V_{IN} to V_{CC} and then lowering it to V_{IH} min.

An external driver must source at least I_{BHLO} to switch this node from low to high.

|| An external driver must sink at least I_{BHHO} to switch this node from high to low.

☆ Current into an output in the high state when $V_O > V_{CC}$

□ High-impedance state during power up or power down

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**electrical characteristics over recommended operating free-air temperature range,
V_{CC} = 3.3 V ± 0.3 V (unless otherwise noted)**

PARAMETER	TEST CONDITIONS	SN54ALVTH16601		SN74ALVTH16601		UNIT		
		MIN	TYP†	MAX	MIN		TYP†	MAX
V _{IK}	V _{CC} = 3 V, I _I = -18 mA			-1.2		-1.2	V	
V _{OH}	V _{CC} = 3 V to 3.6 V, I _{OH} = -100 μA	V _{CC} -0.2		V _{CC} -0.2			V	
	V _{CC} = 3 V, I _{OH} = -24 mA	2						
V _{OL}	V _{CC} = 3 V to 3.6 V, I _{OL} = 100 μA			0.2	0.2		V	
	V _{CC} = 3 V	I _{OL} = 16 mA			0.4			
		I _{OL} = 24 mA			0.5			
		I _{OL} = 32 mA			0.5			
		I _{OL} = 48 mA			0.55			
I _{OL} = 64 mA					0.55			
V _{RST} ‡	V _{CC} = 3.6 V, I _O = 1 mA, V _I = V _{CC} or GND			0.55	0.55		V	
I _I	Control inputs	V _{CC} = 3.6 V, V _I = V _{CC} or GND			±1	±1		μA
		V _{CC} = 0 or 3.6 V, V _I = 5.5 V			10	10		
	A or B ports	V _{CC} = 3.6 V, V _I = 5.5 V			10	10		
		V _{CC} = 3.6 V, V _I = V _{CC}			1	1		
	V _{CC} = 3.6 V, V _I = 0			-5	-5			
I _{off}	V _{CC} = 0, V _I or V _O = 0 to 4.5 V					±100	μA	
I _{BHL} §	V _{CC} = 3 V, V _I = 0.8 V	75			75			μA
I _{BHH} ¶	V _{CC} = 3 V, V _I = 2 V	-75			-75			μA
I _{BHLO} #	V _{CC} = 3.6 V, V _I = 0 to V _{CC}	500			500			μA
I _{BHHO}	V _{CC} = 3.6 V, V _I = 0 to V _{CC}	-500			-500			μA
I _{EX} *	V _{CC} = 3 V, V _O = 5.5 V			125	125		μA	
I _{OZ} (PU/PD)□	V _{CC} ≤ 1.2 V, V _O = 0.5 V to V _{CC} , V _I = GND or V _{CC} , \overline{OE} = don't care			±100	±100		μA	
I _{CC}	V _{CC} = 3.6 V, I _O = 0, V _I = V _{CC} or GND	Outputs high		0.06	0.1	0.06	0.1	mA
		Outputs low		3.5	5	3.5	5	
		Outputs disabled		0.06	0.1	0.06	0.1	
ΔI _{CC} ◇	V _{CC} = 3 V to 3.6 V, One input at V _{CC} - 0.6 V, Other inputs at V _{CC} or GND			0.4	0.4		mA	
C _i	V _{CC} = 3.3 V, V _I = 3.3 V or 0			3	3		pF	
C _{io}	V _{CC} = 3.3 V, V _O = 3.3 V or 0			7	7		pF	

† All typical values are at V_{CC} = 3.3 V, T_A = 25°C.

‡ Data must not be loaded into the flip-flops/latches after applying power.

§ The bus-hold circuit can sink at least the minimum low sustaining current at V_{IL} max. I_{BHL} should be measured after lowering V_{IN} to GND and then raising it to V_{IL} max.

¶ The bus-hold circuit can source at least the minimum high sustaining current at V_{IH} min. I_{BHH} should be measured after raising V_{IN} to V_{CC} and then lowering it to V_{IH} min.

An external driver must source at least I_{BHLO} to switch this node from low to high.

|| An external driver must sink at least I_{BHHO} to switch this node from high to low.

* Current into an output in the high state when V_O > V_{CC}

□ High-impedance state during power up or power down

◇ This is the increase in supply current for each input that is at the specified TTL voltage level rather than V_{CC} or GND.

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timing requirements over recommended operating free-air temperature range, $V_{CC} = 2.5 V \pm 0.2 V$ (unless otherwise noted) (see Figure 1)

			SN54ALVTH16601		SN74ALVTH16601		UNIT
			MIN	MAX	MIN	MAX	
f_{clock}	Clock frequency		150		150		MHz
t_w	Pulse duration	LE high	1.8		1.8		ns
		CLK high or low	2.3		2.3		
t_{su}	Setup time	A or B before CLK \uparrow	Data high	4		4	ns
			Data low	5.2		5.2	
		A or B before LE \downarrow	CLK high	0.7		0.7	
			CLK low	0.9		0.9	
		\overline{CLKEN} before CLK \uparrow	Data high	1.7		1.7	
			Data low	2.3		2.3	
t_h	Hold time	A or B after CLK \uparrow	Data high	0.5		0.5	ns
			Data low	0.5		0.5	
		A or B after LE \downarrow	CLK high	2.3		2.3	
			CLK low	2.4		2.4	
		\overline{CLKEN} after CLK \uparrow	Data high	0.5		0.5	
			Data low	0.5		0.5	

timing requirements over recommended operating free-air temperature range, $V_{CC} = 3.3 V \pm 0.3 V$ (unless otherwise noted) (see Figure 2)

			SN54ALVTH16601		SN74ALVTH16601		UNIT
			MIN	MAX	MIN	MAX	
f_{clock}	Clock frequency		150		150		MHz
t_w	Pulse duration	LE high	1.8		1.8		ns
		CLK high or low	2.3		2.3		
t_{su}	Setup time	A or B before CLK \uparrow	Data high	2.4		2.4	ns
			Data low	3.8		3.8	
		A or B before LE \downarrow	CLK high	1		1	
			CLK low	0.6		0.6	
		\overline{CLKEN} before CLK \uparrow	Data high	1.4		1.4	
			Data low	1.9		1.9	
t_h	Hold time	A or B after CLK \uparrow	Data high	0.5		0.5	ns
			Data low	0.5		0.5	
		A or B after LE \downarrow	CLK high	2		2	
			CLK low	2.3		2.3	
		\overline{CLKEN} after CLK \uparrow	Data high	0.6		0.6	
			Data low	0.5		0.5	

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switching characteristics over recommended operating free-air temperature range, $C_L = 30$ pF, $V_{CC} = 2.5$ V \pm 0.2 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	SN54ALVTH16601		SN74ALVTH16601		UNIT
			MIN	MAX	MIN	MAX	
f_{max}			150		150		MHz
t_{PLH}	B or A	A or B	1.1	4.1	1.1	4.1	ns
t_{PHL}			1.6	4.8	1.6	4.8	
t_{PLH}	LEBA or LEAB	A or B	2.1	5	2.1	5	ns
t_{PHL}			2.4	5.4	2.4	5.4	
t_{PLH}	CLKBA or CLKAB	A or B	2	5	2	5	ns
t_{PHL}			2.5	5.9	2.5	5.9	
t_{PZH}	\overline{OEBA} or OEAB	A or B	1.2	4.8	1.2	4.8	ns
t_{PZL}			1	4.6	1	4.6	
t_{PHZ}	\overline{OEBA} or OEAB	A or B	1.2	5.2	1.2	5.2	ns
t_{PLZ}			1	3.9	1	3.9	

switching characteristics over recommended operating free-air temperature range, $C_L = 50$ pF, $V_{CC} = 3.3$ V \pm 0.3 V (unless otherwise noted) (see Figure 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	SN54ALVTH16601		SN74ALVTH16601		UNIT
			MIN	MAX	MIN	MAX	
f_{max}			150		150		MHz
t_{PLH}	B or A	A or B	1.4	3.9	1.4	3.9	ns
t_{PHL}			1.1	3.9	1.1	3.9	
t_{PLH}	LEBA or LEAB	A or B	2	4.6	2	4.6	ns
t_{PHL}			2.1	4.6	2.1	4.6	
t_{PLH}	CLKBA or CLKAB	A or B	1.9	4.5	1.9	4.5	ns
t_{PHL}			2.2	4.6	2.2	4.6	
t_{PZH}	\overline{OEBA} or OEAB	A or B	1	4.2	1	4.2	ns
t_{PZL}			1	4.4	1	4.4	
t_{PHZ}	\overline{OEBA} or OEAB	A or B	1.8	5.3	1.8	5.3	ns
t_{PLZ}			1.7	4.6	1.7	4.6	

PRODUCT PREVIEW information concerns products in the formative or design phase of development. Characteristic data and other specifications are design goals. Texas Instruments reserves the right to change or discontinue these products without notice.

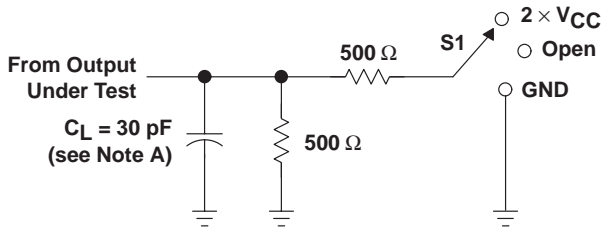


SN54ALVTH16601, SN74ALVTH16601
2.5-V/3.3-V 18-BIT UNIVERSAL BUS TRANSCEIVER
WITH 3-STATE OUTPUTS

SCES143A – SEPTEMBER 1998 – REVISED JULY 1999

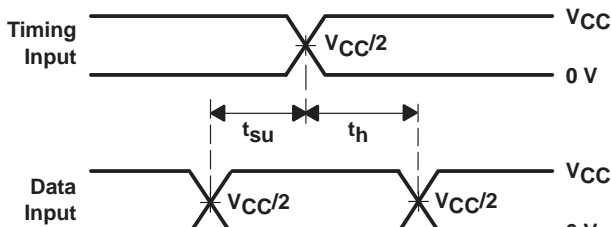
PARAMETER MEASUREMENT INFORMATION

$V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}$

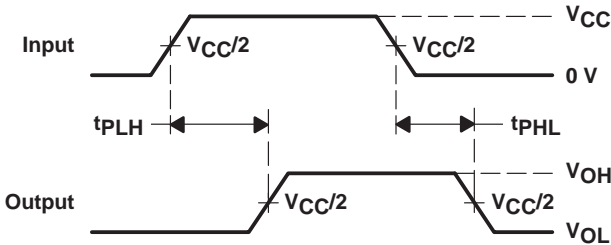


LOAD CIRCUIT

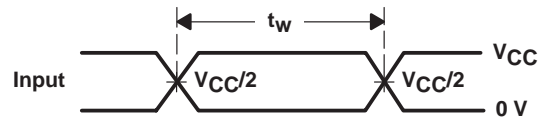
TEST	S1
t_{PLH}/t_{PHL}	Open
t_{PLZ}/t_{PZL}	2 $\times V_{CC}$
t_{PHZ}/t_{PZH}	GND



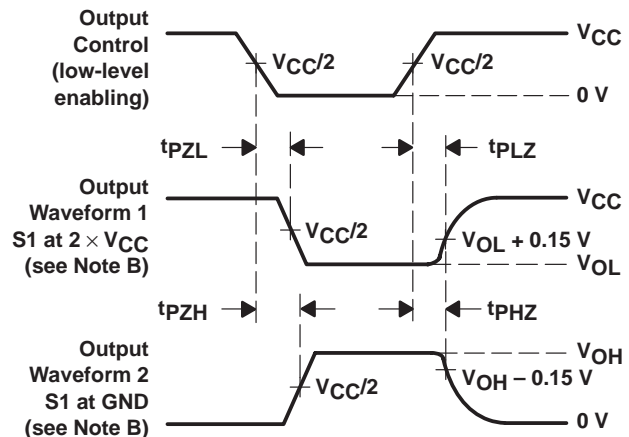
**VOLTAGE WAVEFORMS
SETUP AND HOLD TIMES**



**VOLTAGE WAVEFORMS
PROPAGATION DELAY TIMES**



**VOLTAGE WAVEFORMS
PULSE DURATION**



**VOLTAGE WAVEFORMS
ENABLE AND DISABLE TIMES**

- NOTES: A. C_L includes probe and jig capacitance.
 B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 C. All input pulses are supplied by generators having the following characteristics: PRR $\leq 10\text{ MHz}$, $Z_O = 50\ \Omega$, $t_r \leq 2\text{ ns}$, $t_f \leq 2\text{ ns}$.
 D. The outputs are measured one at a time with one transition per measurement.

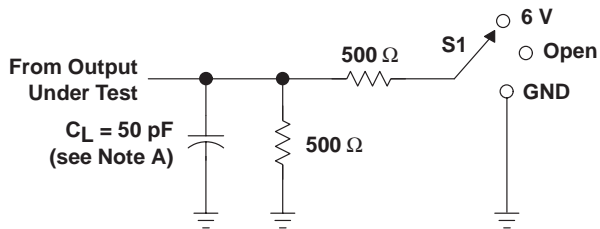
Figure 1. Load Circuit and Voltage Waveforms

SN54ALVTH16601, SN74ALVTH16601
2.5-V/3.3-V 18-BIT UNIVERSAL BUS TRANSCEIVER
WITH 3-STATE OUTPUTS

SCES143A – SEPTEMBER 1998 – REVISED JULY 1999

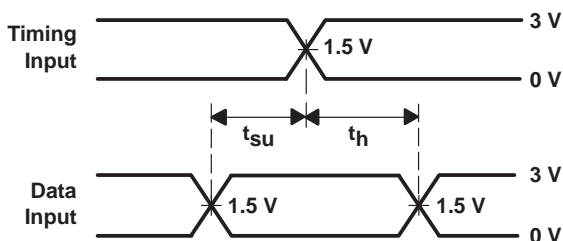
PARAMETER MEASUREMENT INFORMATION

$V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$

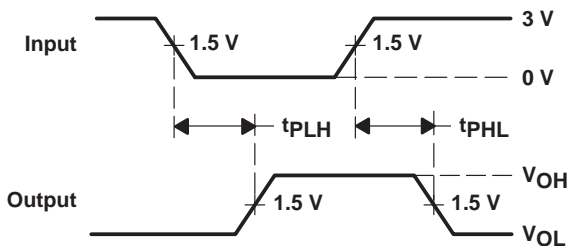


LOAD CIRCUIT

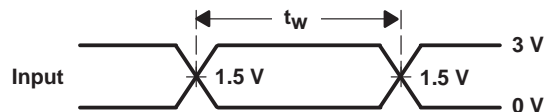
TEST	S1
t_{PLH}/t_{PHL}	Open
t_{PLZ}/t_{PZL}	6 V
t_{PHZ}/t_{PZH}	GND



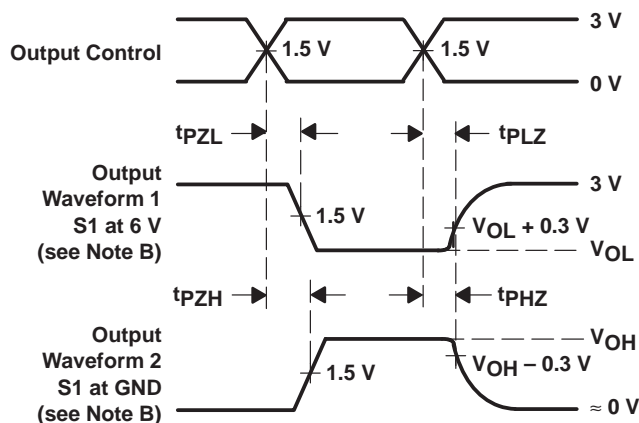
VOLTAGE WAVEFORMS
SETUP AND HOLD TIMES



VOLTAGE WAVEFORMS
PROPAGATION DELAY TIMES
INVERTING AND NONINVERTING OUTPUTS



VOLTAGE WAVEFORMS
PULSE DURATION



VOLTAGE WAVEFORMS
ENABLE AND DISABLE TIMES
LOW- AND HIGH-LEVEL ENABLING

- NOTES: A. C_L includes probe and jig capacitance.
B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
C. All input pulses are supplied by generators having the following characteristics: $PRR \leq 10\text{ MHz}$, $Z_O = 50\ \Omega$, $t_r \leq 2.5\text{ ns}$, $t_f \leq 2.5\text{ ns}$.
D. The outputs are measured one at a time with one transition per measurement.

Figure 2. Load Circuit and Voltage Waveforms

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
SN74ALVTH16601DL	OBSOLETE	SSOP	DL	56		TBD	Call TI	Call TI	-40 to 85	ALVTH16601	
SN74ALVTH16601DLR	OBSOLETE	SSOP	DL	56		TBD	Call TI	Call TI	-40 to 85	ALVTH16601	
SN74ALVTH16601VR	OBSOLETE	TVSOP	DGV	56		TBD	Call TI	Call TI	-40 to 85	VT601	

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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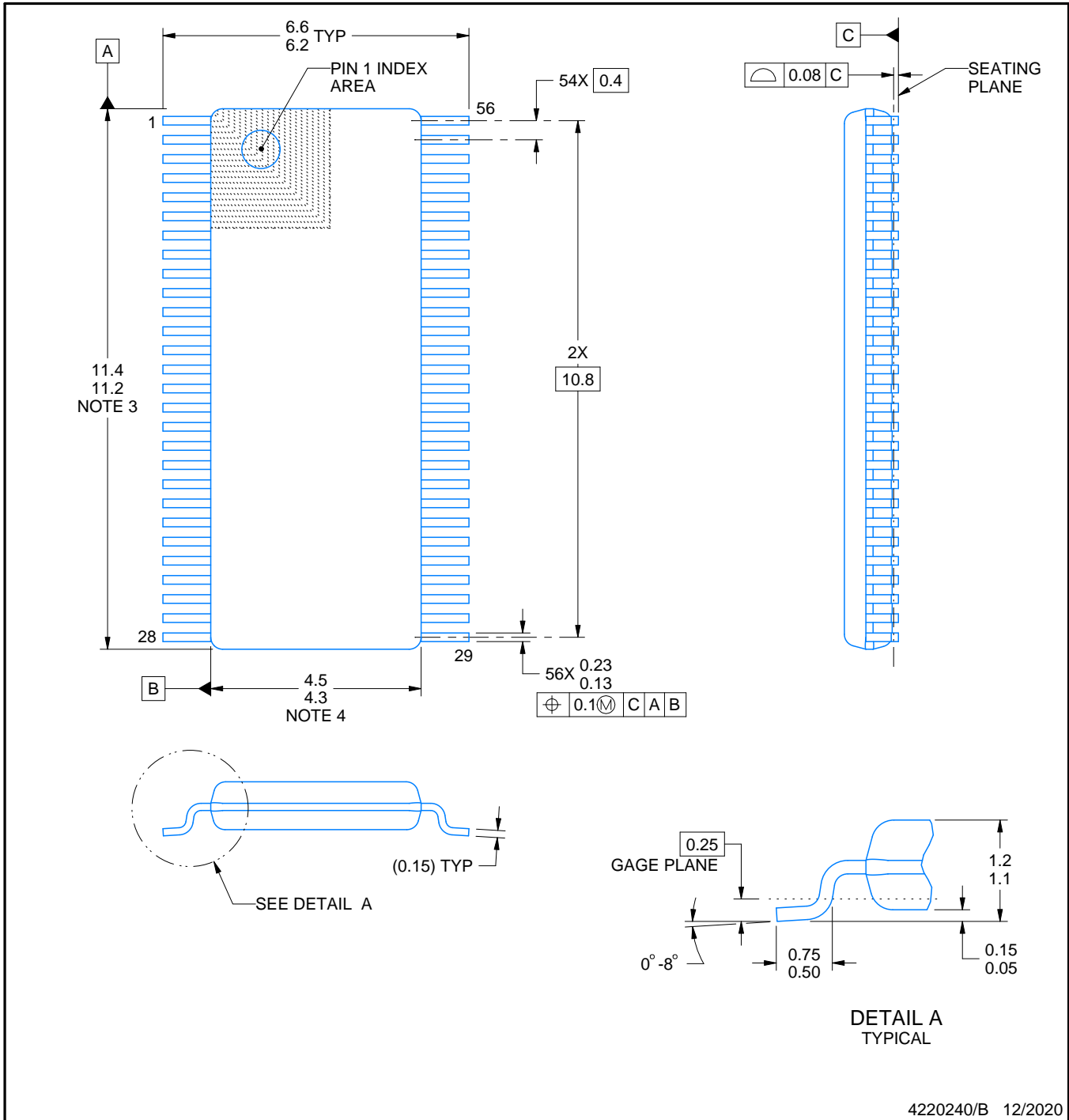
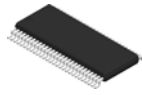
DGV (R-PDSO-G**)

PLASTIC SMALL-OUTLINE

24 PINS SHOWN



- NOTES: A. All linear dimensions are in millimeters.
 B. This drawing is subject to change without notice.
 C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.
 D. Falls within JEDEC: 24/48 Pins – MO-153
 14/16/20/56 Pins – MO-194



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NOTES:

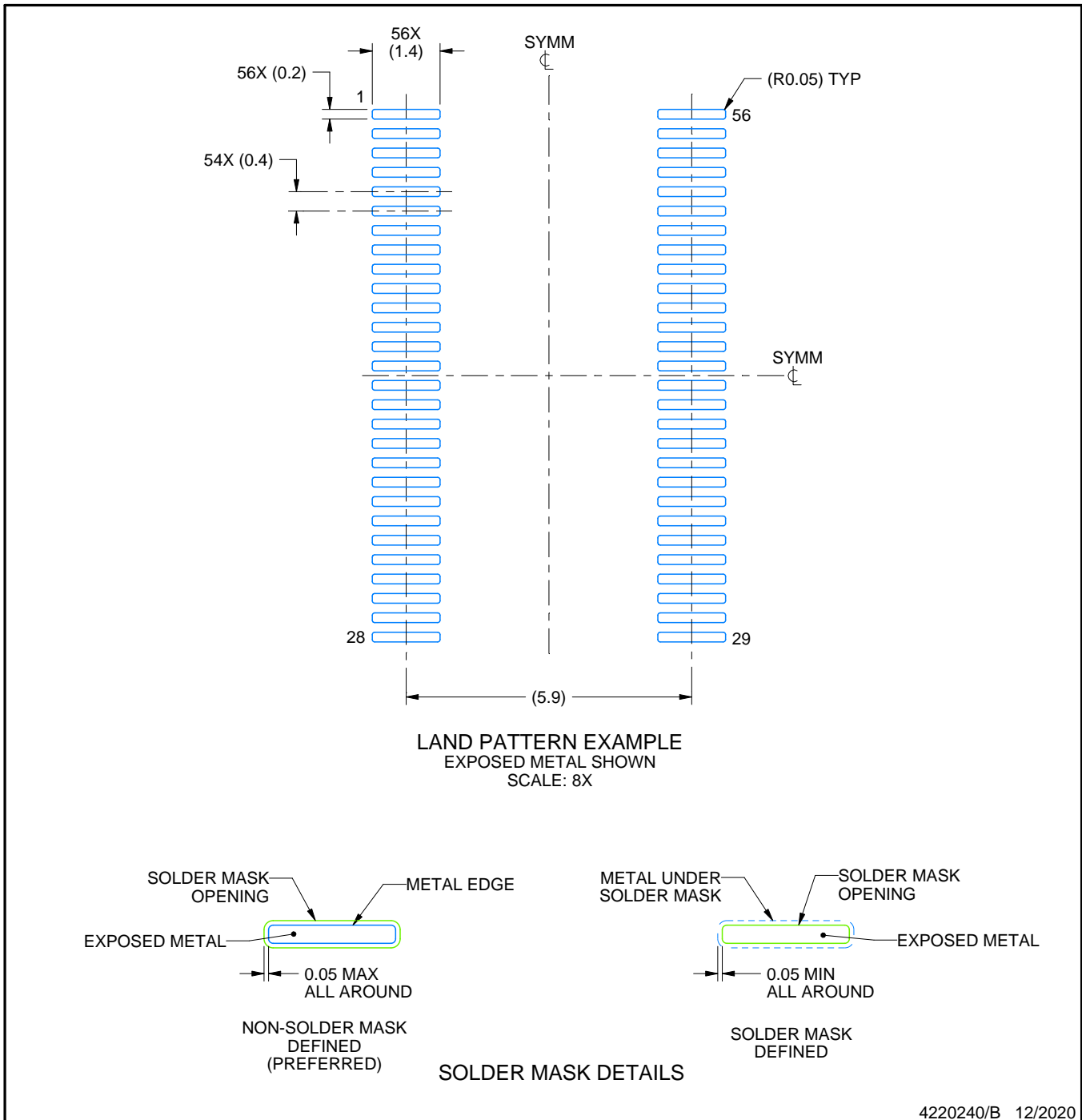
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-194.

EXAMPLE BOARD LAYOUT

DGV0056A

TVSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

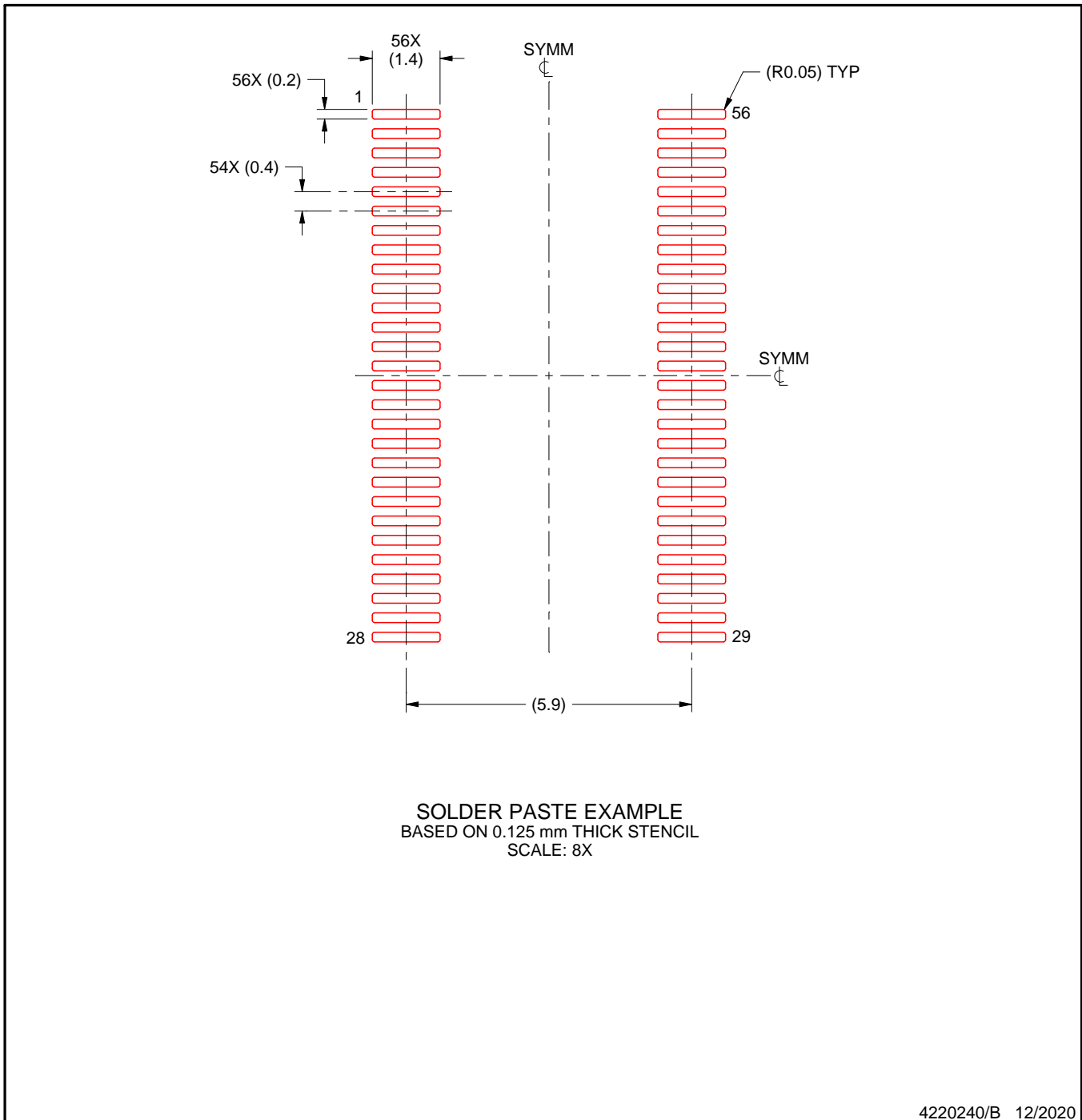
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DGV0056A

TVSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



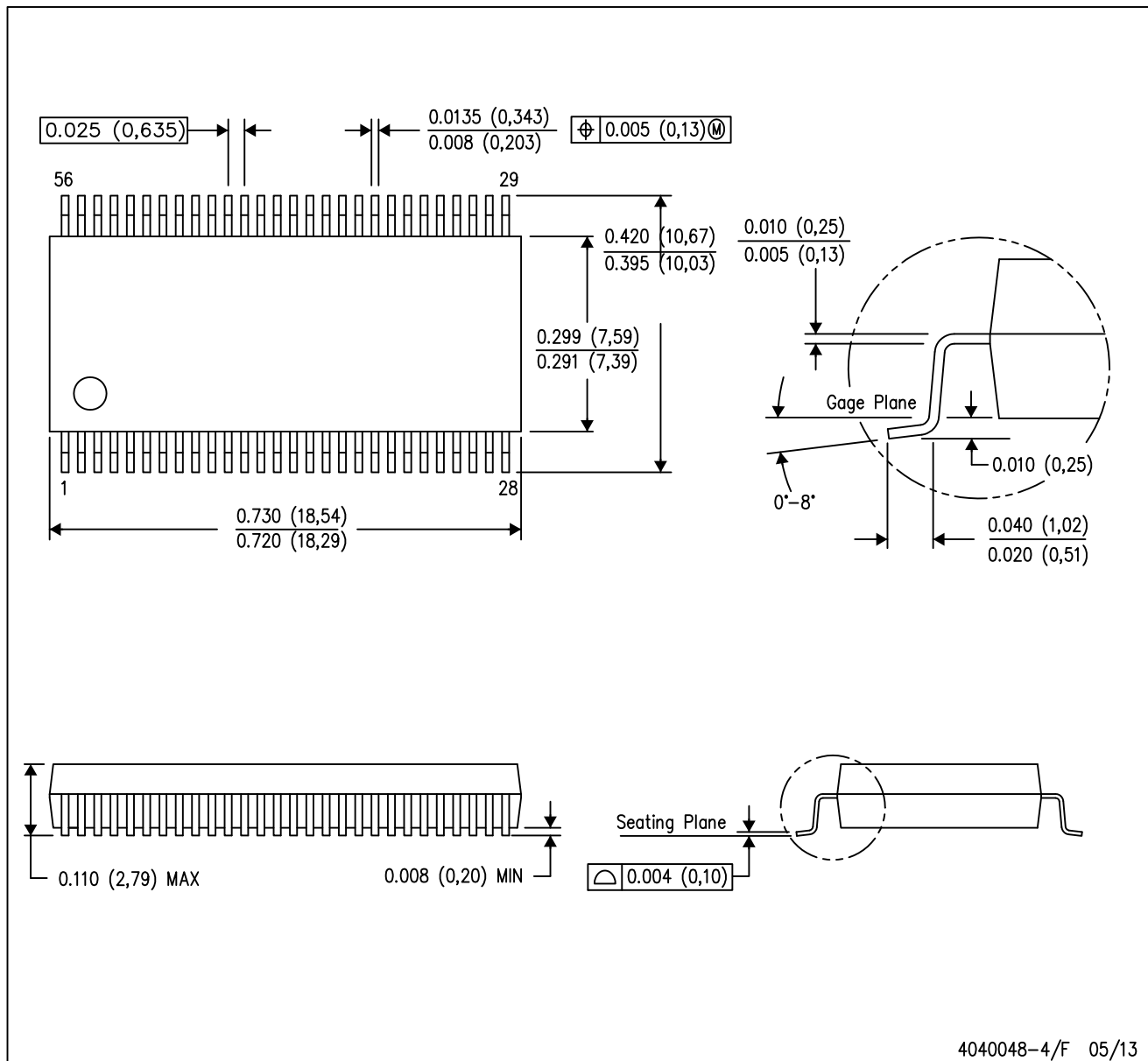
NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

MECHANICAL DATA

DL (R-PDSO-G56)

PLASTIC SMALL-OUTLINE PACKAGE



- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
 - D. Falls within JEDEC MO-118

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